查询"29F52SCX"供应商

FAIRCHILD SEMICONDUCTOR™

April 1988
Revised September 2000

29F52 • 29F53
8-Bit Registered Transceiver

General Description

The 29F52 and 29F53 are 8-bit registered transceivers. Two 8-bit back to back registers store data flowing in both directions between two bidirectional buses. Separate clock, clock enable and 3-STATE output enable signals are provided for each register. The A_0–A_7 output pins are guaranteed to sink 24 mA while the B_0–B_7 output pins are designed for 64 mA.

The 29F53 is an inverting option of the 29F52. Both transceivers are AMD Am2952/2953 functional equivalents.

Features

- 8-bit registered transceivers
- Separate clock, clock enable and 3-STATE output enable provided for each register
- AMD Am2952/2953 functional equivalents
- Both inverting and non-inverting options available
- 24-Pin slimline package

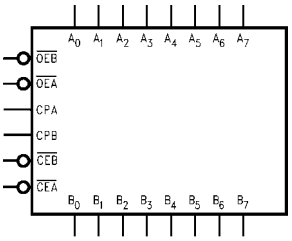
Ordering Code:

Order Number	Package Number	Package Description
29F52SC	M24B	24-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide
29F52SPC	N24C	24-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide
29F53SPC	N24C	24-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide

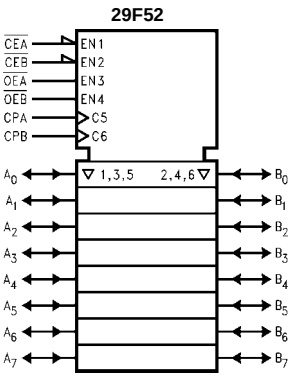
Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Logic Symbols

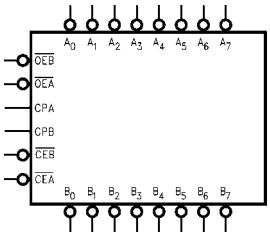
29F52



IEEE/IEC



29F53



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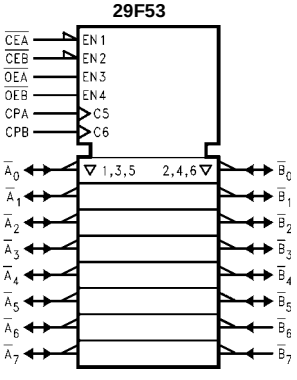

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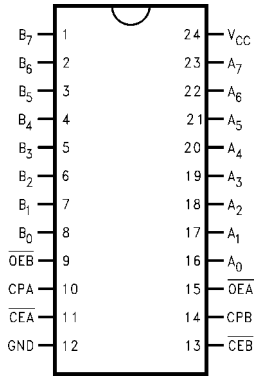
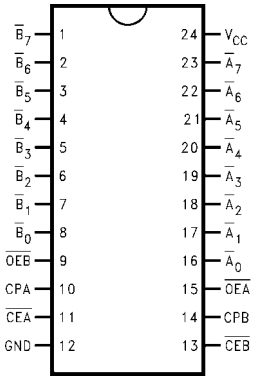
Connection Diagrams

Pin Assignment for DIP and SOIC
29F52



Pin Assignment for DIP
29F53



Unit Loading/Fan Out

Pin Names	Description	U.L. HIGH/LOW	Input I_{IH}/I_{IL} Output I_{OH}/I_{OL}
A_0–A_7	A-Register Inputs/	3.5/1.083	70 µA/0.65 mA
	B-Register 3-STATE Outputs	150/40 (33.3)	–3 mA/24 mA (20 mA)
B_0–B_7	B Register Inputs/	3.5/1.083	70 µA/0.65 mA
	A-Register 3-STATE Outputs	600/106.6 (80)	–12 mA/64 mA (48 mA)
$\overline{OEA}$	Output Enable A-Register	1.0/1.0	20 µA/–0.6 mA
CPA	A-Register Clock	1.0/1.0	20 µA/–0.6 mA
$\overline{CEA}$	A-Register Clock Enable	1.0/1.0	20 µA/–0.6 mA
$\overline{OEB}$	Output Enable B-Register	1.0/1.0	20 µA/–0.6 mA
CPB	B-Register Clock	1.0/1.0	20 µA/–0.6 mA
$\overline{CEB}$	B-Register Clock Enable	1.0/1.0	20 µA/–0.6 mA

Output Control

OE	Internal Q	Y-Output 29F52	Y-Output 29F53	Function
H	X	Z	Z	Disable Outputs
L	L	L	H	Enable Outputs
L	H	H	L	

H = HIGH Voltage Level
L = LOW Voltage Level
X = Immaterial
Z = HIGH Impedance
N = LOW-to-HIGH Transition
NC = No Change

Register Function Table (Applies to A or B Register)

Inputs D	Inputs CP	Inputs CE	Internal Q	Function
X	X	H	NC	Hold Data
L	N	L	L	Load Data
H	N	L	H	

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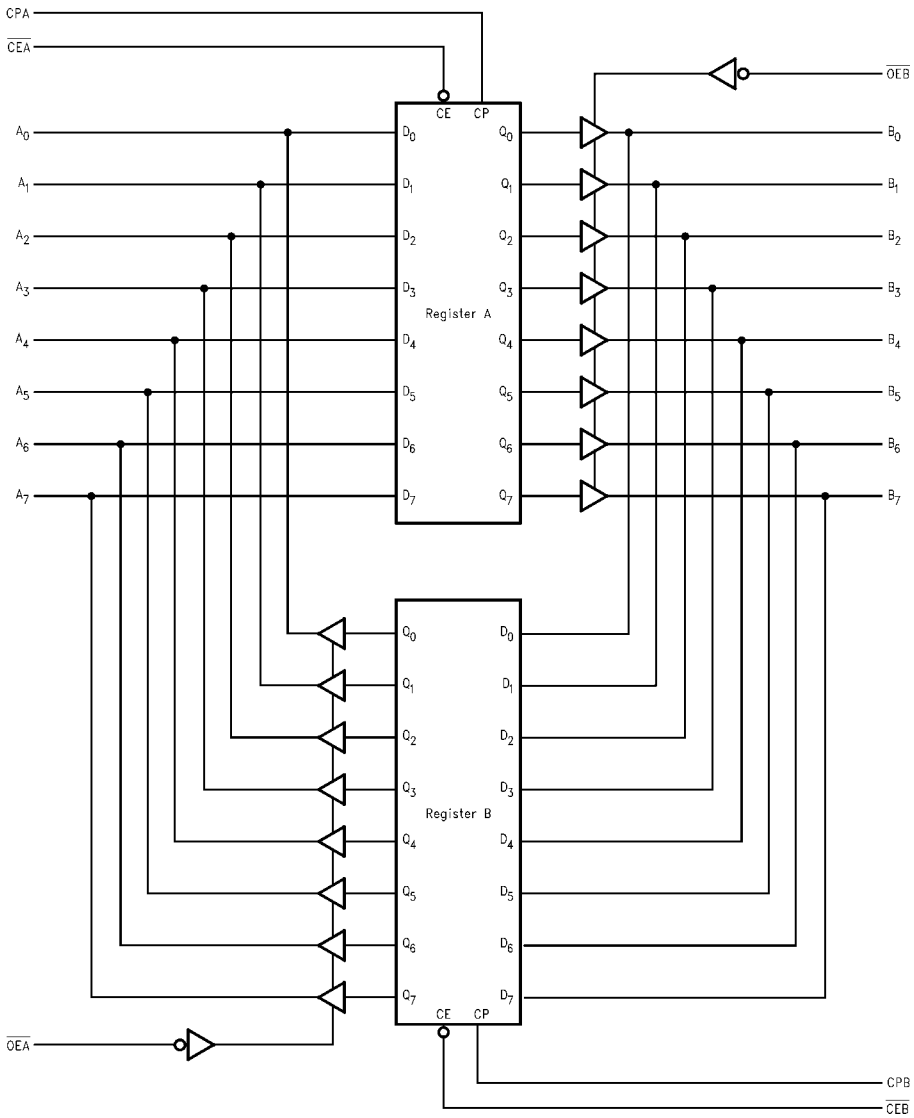
Block Diagrams

29F52



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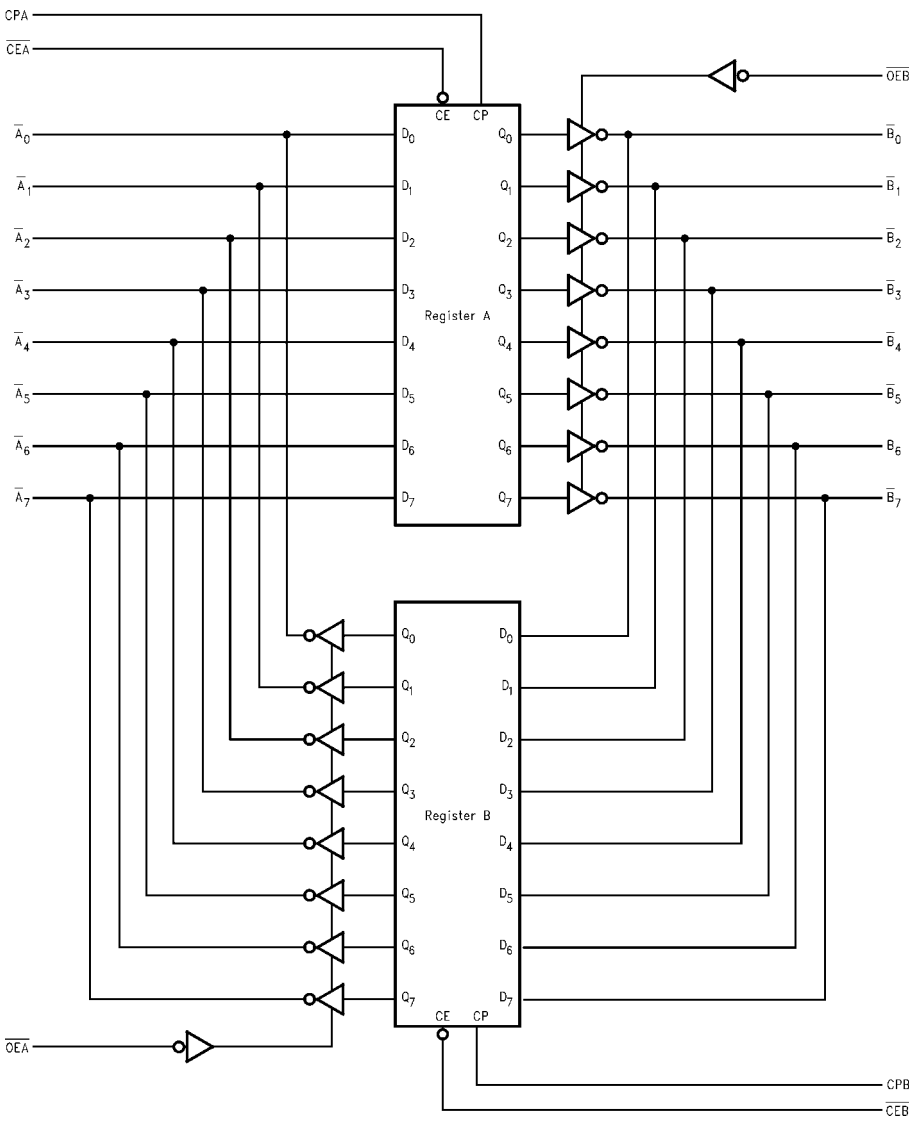
Block Diagrams (Continued)

Block Diagrams (continued)

29F53



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Absolute Maximum Ratings(Note 1)

Storage Temperature	−65°C to +150°C
Ambient Temperature under Bias	−55°C to +125°C
Junction Temperature under Bias	−55°C to +150°C
V_{CC} Pin Potential to Ground Pin	−0.5V to +7.0V
Input Voltage (Note 2)	−0.5V to +7.0V
Input Current (Note 2)	−30 mA to +5.0 mA
Voltage Applied to Output	
in HIGH State (with V_{CC} = 0V)	
Standard Output	−0.5V to V_{CC}
3-STATE Output	−0.5V to +5.5V
Current Applied to Output	
in LOW State (Max)	twice the rated I_{OL} (mA)

Recommended Operating Conditions

Free Air Ambient Temperature	0°C to +70°C
Supply Voltage	+4.5V to +5.5V

Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

DC Electrical Characteristics

Symbol	Parameter		Min	Typ	Max	Units	V_{CC}	Conditions
V_{IH}	Input HIGH Voltage		2.0			V		Recognized as a HIGH Signal
V_{IL}	Input LOW Voltage				0.8	V		Recognized as a LOW Signal
V_{CD}	Input Clamp Diode Voltage				−1.2	V	Min	I_{IN} = −18 mA (Non I/O Pins)
V_{OH}	Output HIGH	10% V_{CC}	2.5					I_{OH} = −1 mA (A_n)
	Voltage	10% V_{CC}	2.4					I_{OH} = −3 mA (A_n, B_n)
		10% V_{CC}	2.0			V	Min	I_{OH} = −15 mA (B_n)
		5% V_{CC}	2.7					I_{OH} = −1 mA (A_n)
		5% V_{CC}	2.7					I_{OH} = −3 mA (A_n, B_n)
V_{OL}	Output LOW	10% V_{CC}			0.5	V	Min	I_{OL} = 24 mA (A_n)
	Voltage	10% V_{CC}			0.55			I_{OL} = 64 mA (B_n)
I_{IH}	Input HIGH Current				20	µA	Max	V_{IN} = 2.7V (Non-I/O Pins)
I_{BVI}	Input HIGH Current Breakdown Test				100	µA	Max	V_{IN} = 7.0V (Non-I/O Pins)
I_{BVIT}	Input HIGH Current Breakdown Test (I/O)				1.0	mA	Max	V_{IN} = 5.5V (A_n, B_n)
I_{IL}	Input LOW Current				−0.6	mA	Max	V_{IN} = 0.5V (Non-I/O Pins)
$I_{IH} + I_{OZH}$	Output Leakage Current				70	µA	Max	V_{OUT} = 2.7V (A_n, B_n)
$I_{IL} + I_{OZL}$	Output Leakage Current				−650	µA	Max	V_{OUT} = 0.5V (A_n, B_n)
I_{OS}	Output Short-Circuit Current		−60		−150	mA	Max	V_{OUT} = 0V (A_n)
			−100		−225			V_{OUT} = 0V (B_n)
I_{CEX}	Output HIGH Leakage Current				250	µA	Max	V_{OUT} = V_{CC} (A_n, B_n)
I_{ZZ}	Bus Drainage Test				500	µA	0.0V	V_{OUT} = 5.25V (A_n, B_n)
I_{CCH}	Power Supply Current			130	190	mA	Max	V_O = HIGH
I_{CCL}	Power Supply Current				190	mA	Max	V_O = LOW
I_{CCZ}	Power Supply Current				190	mA	Max	V_O = HIGH Z

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AC Electrical Characteristics

Symbol	Parameter	$T_A = +25°C$, $V_{CC} = +5.0V$, $C_L = 50$ pF			$T_A = -55°C$ to $+125°C$, $V_{CC} = +5.0V$, $C_L = 50$ pF		$T_A = 0°C$ to $+70°C$, $V_{CC} = +5.0V$, $C_L = 50$ pF		Units
		Min	Typ	Max	Min	Max	Min	Max	
t_{PLH}	Propagation Delay	3.0	5.5	7.5			2.5	8.5	ns
t_{PHL}	CPA or CPB to A_n or B_n	4.0	7.0	9.0			3.5	10.0	
t_{PZH}	Output Enable Time	2.5	5.5	7.5			2.0	8.5	ns
t_{PZL}	$\overline{OEA}$ or $\overline{OEB}$ to A_n or B_n	3.5	7.0	9.5			3.0	10.5	
t_{PHZ}	Output Disable Time	2.5	6.5	9.0			2.0	10.0	ns
t_{PLZ}	$\overline{OEA}$ or $\overline{OEB}$ to A_n or B_n	2.5	5.5	7.5			2.0	8.5	

AC Operating Requirements

Symbol	Parameter	$T_A = +25°C$, $V_{CC} = +5.0V$		$T_A = -55°C$ to $+125°C$, $V_{CC} = +5.0V$		$T_A = 0°C$ to $+70°C$, $V_{CC} = +5.0V$		Units
		Min	Max	Min	Max	Min	Max	
$t_S(H)$	Setup Time, HIGH or LOW	4.0				4.5		ns
$t_S(L)$	A_n or B_n to CPA or CPB	4.0				4.5		
$t_H(H)$	Hold Time, HIGH or LOW	2.0				2.5		ns
$t_H(L)$	A_n or B_n to CPA or CPB	2.0				2.5		
$t_S(H)$	Setup Time, HIGH or LOW	1.0				1.5		ns
$t_S(L)$	$\overline{CEA}$ or $\overline{CEB}$ to CPA or CPB	4.0				4.5		
$t_H(H)$	Hold Time, HIGH or LOW	2.0				2.5		ns
$t_H(L)$	$\overline{CEA}$ or $\overline{CEB}$ to CPA or CPB	2.0				2.5		
$t_W(H)$	Pulse Width, HIGH or LOW	3.0				3.5		ns
$t_W(L)$	CPA or CPB	3.0				3.5		

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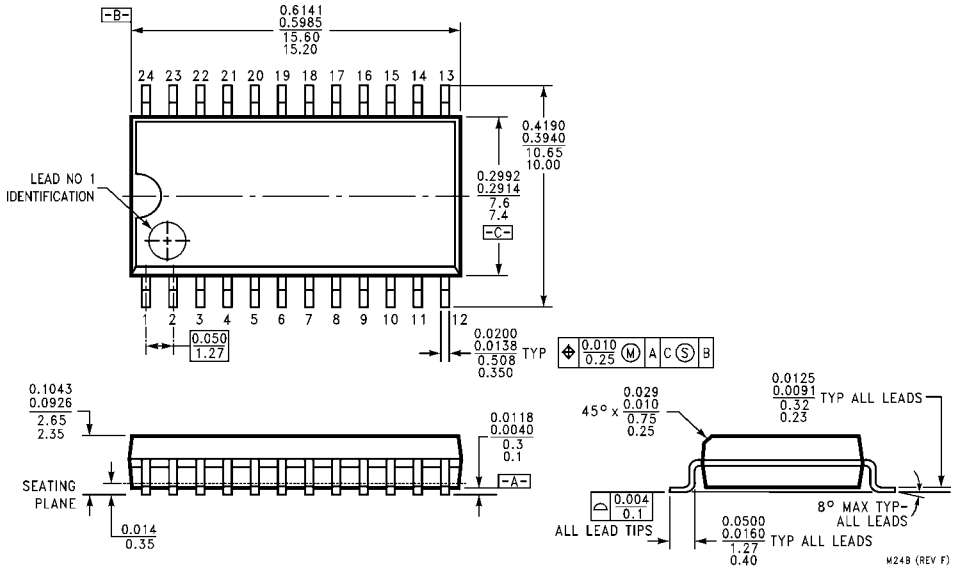
Physical Dimensions inches (millimeters) unless otherwise noted



24-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide
Package Number M24B

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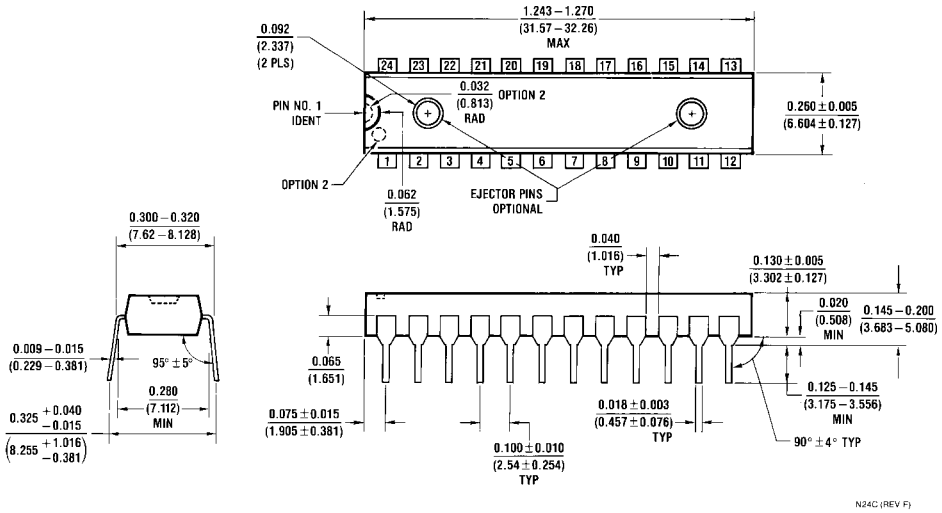
Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



24-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide
Package Number N24C

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